

## MS7N60

### N-Channel Enhancement Mode Power MOSFET

### **Description**

The MS7N60 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220AB package is universally preferred for all commercial-industrial applications

#### Features

- · Low On Resistance
- · Simple Drive Requirement
- · Low Gate Charge
- · Fast Switching Characteristic
- RoHS compliant package

### Application

- Adapter
- · Switching Mode Power Supply

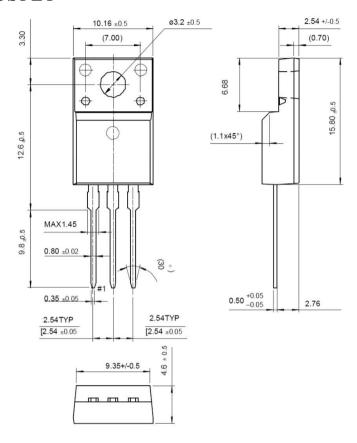
Package type: TO-220AB

Packing & Order Information

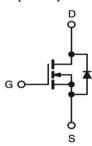
50/Tube; 1,000/Box







### Graphic symbol



### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (Tc=25°C unless otherwise specified)							
Symbol	Parameter	Value	Unit				
$V_{DSS}$	Drain-Source Voltage	600	V				
$V_{GS}$	Gate-Source Voltage	±30	V				
T	Drain Current -Continuous (TC=25°C)	7.0	A				
I <sub>D</sub>	Drain Current -Continuous (TC=100°C)	4.4	A				
I <sub>DM</sub>	Drain Current Pulsed	28	A				
$I_{AR}$	Avalanche Current	7.0	V				
Eas	Single Pulsed Avalanche Energy	187	mJ				
E <sub>AR</sub>	Repetitive Avalanche Energy	7.0	mJ				
dv/dt	Peak Diode Recovery dv/dt	4.4	V/ns				

<sup>•</sup> Drain current limited by maximum junction temperature



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Absolute Maximum Ratings (Tc=25°C unless otherwise specified)						
Symbol	Parameter	Value Unit				
$T_{ m L}$	Maximum Temperature for Soldering @ Lead at 0.125 in(0.318mm) from case for 10 seconds	300	°C			
$T_{ m PKG}$	Maximum Temperature for Soldering @ Package Body for 10 seconds	260	°C			
P <sub>D</sub>	Total Power Dissipation(@TC = 25 °C) 44 W	44	W			
	Derating Factor above 25 °C	0.35	W/°C			
$T_{STG}$	Operating and Storage Temperature	-55 to +150	°C			
$T_{\mathrm{J}}$	Storage Temperature	150	°C			

### Note:

- 1. Repetitive rating; pulse width limited by maximum junction temperature.
- 2.  $I_{AS} \le 7A$ ,  $V_{DD} = 50V$ , L = 7mH,  $V_G = 10V$ , starting TJ = +25°C.
- 3. I<sub>SD</sub>≤7A, dI/dt≤200A/µs, VDD≤BVDSS, starting TJ=+25°C.

Thermal Characteristics						
Symbol Parameter Min. Typ. Max. Units						
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case			1.25	°C/W	
RөJA	Thermal Resistance, Junction-to-Ambient			62.5	C/W	

Static Characteristics						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0~V~,~I_D\!=250\mu\text{A}$	600			V
$\Delta BV_{DSS}$ $/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		0.60		V/°C
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \text{ uA}$	2.0		4.0	V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS} = 600 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 480 \text{ V}, T_{C} = 125 ^{\circ}\text{C}$			1 10	uA
I <sub>GSS</sub>	Gate-Body Leakage, Forward	$V_{GS} = \pm 30$			±100	nA
$R_{\rm DS(ON)}$	Static Drain-Source On-state Resistance	$V_{GS} =$ -10 V , $I_D =$ 3.5 V		1.08	1.2	Ω

Dynamic Characteristics								
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units		
C <sub>ISS</sub>	Input Capacitance	$V_{DS}$ =25V, $V_{GS}$ =0V, $f$ =1.0MHz		1332		pF		
Coss	Output Capacitance			114		pF		
$C_{RSS}$	Reverse Transfer Capacitance			61		pF		



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Dynamic Characteristics							
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units	
$t_{d(on)}$	Turn-On Time	$V_{DS} = 300 \text{ V}, I_{D} = 6 \text{ A}, \\ V_{GS} = 10 \text{ V}, R_{G} = 25 \Omega$		14.2		ns	
$t_r$	Rise Time			40		ns	
$t_{\rm d(off)}$	Turn-Off Delay Time			31.5		ns	
tf	Fall Time			32.3		ns	
Qg	Total Gate Charge	$V_{DS} = 300 \text{ V}, I_{D} = 6 \text{ A},$ $V_{GS} = 10 \text{ V}$		37		nC	
$Q_{gs}$	Gate-Source Charge			6.0		nC	
$Q_{\mathrm{gd}}$	Gate-Drain Charge (Miller Charge)			17.9		nC	

Source-Drain Diode						
Symbol	Parameter	Test Conditions	Min	Typ.	Max.	Units
Is		$V_D = V_G = 0,$			7.0	A
I <sub>SM</sub>		$V_S = 1.3 V$			28	
V <sub>SD</sub>		$I_S = 7 A, V_{GS} = 0 V$			1.5	V
$t_{rr}$		$I_S = 6 A$ , $V_{GS} = 0 V$		504.9		ns
Qrr		diF/dt=100A/μs		47.59		uC

<sup>\*</sup>Pulse Test : Pulse Width ≤300µs, Duty Cycle≤2%



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